## IN THE CLAIMS

Please add new claims 19-26, and amend claims 1-18 as follows:

- 1. (CURRENTLY AMENDED) A gallium Group-III nitride (GaN) based light emitting diode (LED), wherein light is extracted through a surface of the nitrogen face (N-face) of the Group-III nitride based LED and a the surface of the N-face of the Group-III nitride based LED is roughened structured so that the light is extracted out of the Group-III nitride based LED.
- 2. (CURRENTLY AMENDED) The GaN LED of claim 1, wherein the surface of the N-face is roughened structured into one or more cones.
- 3. (CURRENTLY AMENDED) The GaN LED of claim 1, wherein the roughened structured surface reduces light reflections occurring repeatedly inside the LED, and thus extracts more light out of the LED.
- 4. (CURRENTLY AMENDED) The GaN LED of claim 1, wherein the surface of the N-face is roughened structured by an anisotropic etching.
- 5. (CURRENTLY AMENDED) The GaN LED of claim 4, wherein the anisotropic etching is a dry etching.
- 6. (CURRENTLY AMENDED) The GaN LED of claim [[4]] 25, wherein the anisotropic wet etching is a photo-enhanced chemical (PEC) etching.
- 7. (CURRENTLY AMENDED) The GaN LED of claim 1, wherein the N-face is an n-type layer of the GaN LED.
- 8. (CURRENTLY AMENDED) The GaN LED of claim 1, wherein the N-face is prepared by a laser lift off (LLO) technique.

- 9. (CURRENTLY AMENDED) The GaN LED of claim 1, wherein the LED is grown on a c-plane GaN wafer and a gallium face (Ga-face) is a p-type layer.
- 10. (CURRENTLY AMENDED) The GaN LED of claim 1, wherein the LED is comprised of an n-type electrode, n-type layer, active region, p-type layer and p-type electrode.
- 11. (CURRENTLY AMENDED) The GaN LED of claim 10, wherein the n-type layer, active region and p-type layer are each comprised of a (B, Al, Ga, In)N alloy.
- 12. (CURRENTLY AMENDED) The GaN LED of claim 10, wherein the p-type electrode has a property of high reflection to decrease light absorption and to increase light reflection toward the surface of the n-type layer.
- 13. (CURRENTLY AMENDED) The GaN LED of claim 10, wherein the LED includes a current-blocking layer aligned under the n-type electrode to keep the current from concentrating below the n-type electrode, so that absorption of light emission under the n-type electrode can be avoided and extraction efficiency can be increased.
- 14. (CURRENTLY AMENDED) The GaN LED of claim 10, wherein the LED includes a current-confining frame made of an insulator to restrain leakage current through the sidewalls of the LED without significantly decreasing an emitting area.
- 15. (CURRENTLY AMENDED) The GaN LED of claim 2, wherein the roughened structured surface is comprised of a plurality of hexagonal shaped cones that have an angle equal to or smaller than:

$$2\sin^{-1}(n_{air}/n_s)\approx 47.2^\circ$$

for GaN, where  $n_{air}$  is a refractive index of air and  $n_s$  is a refractive index of GaN the Group-III nitride.

16. (CURRENTLY AMENDED) The GaN LED of claim 2, wherein the roughened structured surface is comprised of a plurality of hexagonal shaped cones that have an angle equal to or smaller than:

$$2\sin^{-1}(n_{enc}/n_s)$$

for epoxy, where  $n_{enc}$  is a refractive index of epoxy and  $n_s$  is a refractive index of GaN the Group-III nitride.

17. (CURRENTLY AMENDED) A method of creating a gallium Group-III nitride (GaN) based light emitting diode (LED), wherein light is extracted through a structured surface of a nitrogen face (N-face) of the LED, comprising:

roughening a structuring the surface of the N-face into one or more cones after growth to extract light out of the Group-III nitride based LED.

- 18. (CURRENTLY AMENDED) A <u>Group-III nitride based</u> light emitting diode (LED) comprised of an n-type electrode, n-type layer, active region, p-type layer and p-type electrode, wherein a <u>nitrogen face (N-face)</u> surface of the n-type layer is <del>roughened by an anisotropic</del> etching into one or more cones and <u>structured after growth</u>, so that light is extracted through the <u>roughened structured N-face</u> surface of the n-type layer.
- 19. (NEW) The method of claim 17, wherein the surface of the N-face is structured into one or more cones.
- 20. (NEW) The method of claim 17, wherein the N-face surface of the n-type layer is structured using an anisotropic etching.
  - 21. (NEW) The method of claim 20, wherein the anisotropic etching is a dry etching.
  - 22. (NEW) The method of claim 20, wherein the anisotropic etching is a wet etching.

- 23. (NEW) The method of claim 22, wherein the wet etching is a photo-enhanced chemical (PEC) etching.
- 24. (NEW) The method of claim 17, wherein the surface of the N-face is structured by roughening or patterning.
  - 25. (NEW) The LED of claim 4, wherein the anisotropic etching is a wet etching.
- 26. (NEW) The LED of claim 1, wherein the surface of the N-face is structured by roughening or patterning.